

<b>Notice of References Cited</b>	Application/Control No. 10/598,171		Applicant(s)/Patent Under Reexamination BUTLIN ET AL.	
	Examiner RASHAWN TILLERY		Art Unit 2174	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,993,362	01-2006	Aberg, Kristoffer	455/566
*	B	US-2005/0108657	05-2005	Han, Jea-Hun	715/827
*	C	US-2005/0277432	12-2005	Viana et al.	455/466
*	D	US-2004/0261031	12-2004	Tuomainen et al.	715/739
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	GB 2293951 A	04-1996	United Kingdom	SORENSEN et al.	
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.